

Ion Implantation and Applications for Power Devices

Outline

Introduction

Silicon carbide doping challenges
Implant Species and Source Operation
High Temperature Implant for Implant Damage Control

Silicon Carbide Structure and Implant Solutions High Energy Implant for SiC Trench MOSFET Purion XEmax High Energy System

Summary



Axcelis at a Glance

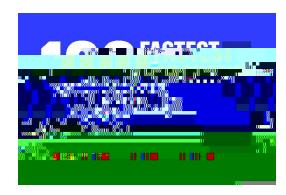
Global leader in technology development and manufacturing of ion implant systems and services for the semiconductor industry for 45 years

- Serving the ~\$2.7B ion implant systems market
- Based in Beverly, MA with headcount greater than 1700 worldwide
- Global customer support infrastructure
- Growing installed base of greater than 3000 tools
- Strong IP portfolio

Supplier of record to leading semiconductor CAPEX spenders in all market segments including DRAM, NAND, Foundry, Logic, Power and Image Sensor



axcelis





Product Overview - Common Purion Platform

Application Space	High Current	Medium Energy/ High Current	Medium Energy/ Medium Current	High Energy
Base Products/Model	Purion H Purion Dragon	Purion H200	Purion M	Purion XE/EXE/VXE Purion XEmax
Power Series™		Purion H200 SiC	Purion M SiC	Purion XE/EXE SiC
Customer Markets	Adv DRAM/NAND & Logic Material Modification	Power Device Mature Technologies	Power Device RF Mature Technologies Adv DRAM/NAND	Power Device Image Sensor Mature Technologies Adv DRAM/NAND



Silicon Carbide Doping Challenges

Aluminium: P-type dopant Solid source vaporizer like, All



Implant and Annealing Strategy



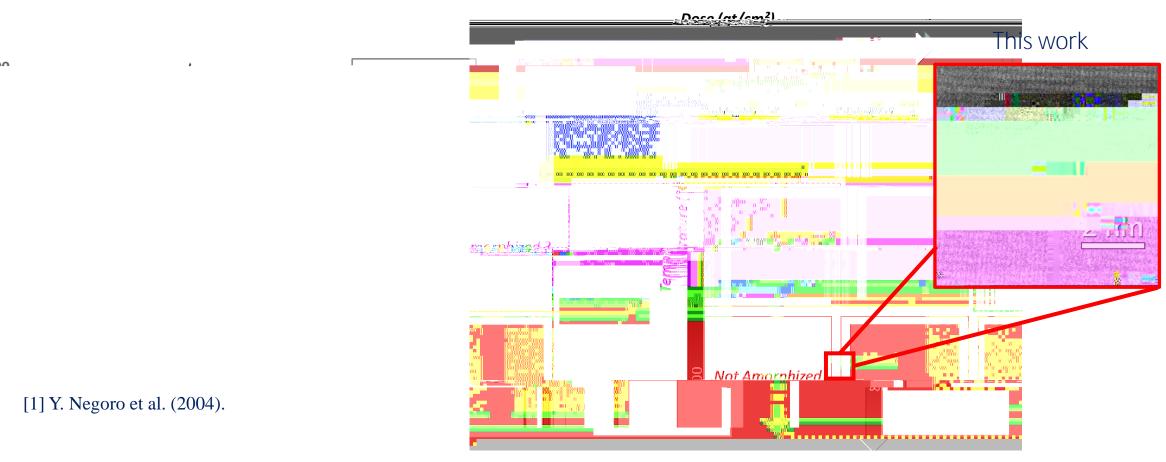
Advanced ion implantation Control & Minimize defect level

Avoid capping layer process and to reduce manufacturing costs

Laser annealing to combine high temperature activation efficiency with no high thermal budget-induced extending defects



Hot Implant and Annealing Control to Implant Damages

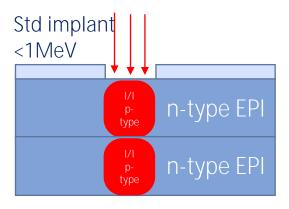


High Temperature Implant for SiC Implant Defect Control "Warm" or Room Temperature Implants at Lower Lose for Productivity Consideration



Super Junction Formation and High Energy Implant

(Multi-step) n-EPI/p-type implant

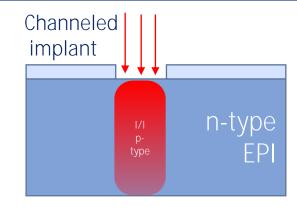


Process (Multi Epi/Implant Step):
Each n-type EPI (literature 0.7-0.8um)
Masking and opening at p-type pillar
Compensating implant

Repeat

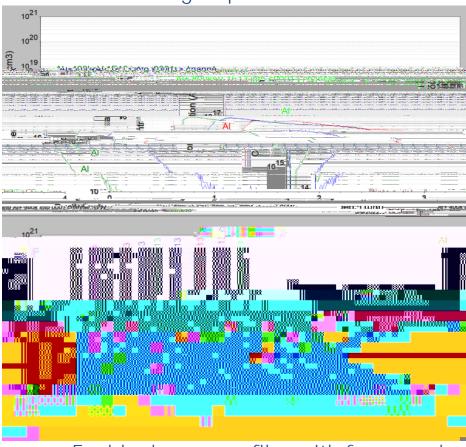
Kobayashi, Y. et al. (2019). (ISPSD) (pp. 31-34). IEEE.

n-type (EPI) + p-type implant



Process (Single Epi Step):
n-type EPI (final thickness)
Masking and opening at p-type pillar
Multiple implants or channeling
implants

Channeling Implant Profiles

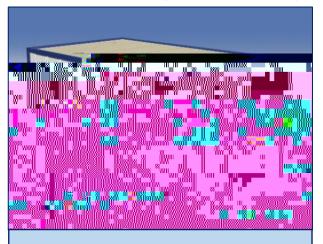


Enable deeper profiles with fewer and lower energy implants

Implant angle accuracy for channeling profile control



Axcelis High Energy Implant Systems



Purion XE/EXE/VXE Purion XEmax

Purion XE/EXE SiC

Power Device Image Sensor Mature Technologies Adv DRAM/NAND Linear acceleration (LINAC) technology

Market leader

High productivity

Reliable and cost effective

High temperature implant for SiC

Purion XE

Purion EXE

New developed systems:

Purion XEmax

- Ultra high energy system (15MeV)
- To satisfy implant roadmap requirement

Axcelis Offers Complete Set of High Energy Systems for IC Manufacturing



Purion XEmax High Energy System

Designed to achieve high energy implant capability
Higher extraction current
Longer source life

Booster module acceleration

Select higher charge state ion after booster

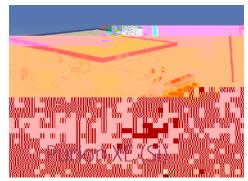
Eliminate energetic contaminants generated from ion source

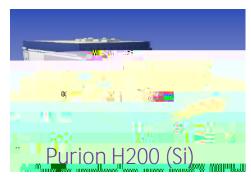
S bend corrector magnet



Axcelis Purion Power Series for SiC Highest Productivity Solution for ALL Implants in SiC HVM







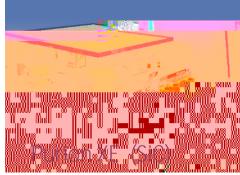
Al+ Source

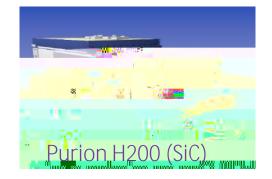
150/200mm SiC
Wafer Handling

Heated Implant
Capability (650°C)









Energy Range (keV)

Species	М	XE	H200
+	335	1200	200
++	670	2700	400
+++	1000	3500	



Axcelis makes critical R&D investments to fuel continued innovation that further differentiates our products

Axcelis tools provide a variety of competitive advantages across all customer segments

Axcelis provides SiC implantation solutions

Medium energy with high current implant capability

Provide high temperature implant capability with high productivity

Provide high energy system for profile optimization/engineering



